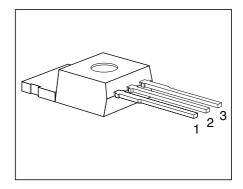


## Features

- N channel
- Logic level
- Enhancement mode
- Temperature sensor with thyristor characteristic
  The drain pin is electrically shorted to the tab



Pin	1	2	3
	G	D	S

Туре	V <sub>DS</sub>	ID	R <sub>DS(on)</sub>	Package	Ordering Code
BTS 132	60 V	24 A	0.065 Ω	TO-220AB	C67078-A5003-A4

## **Maximum Ratings**

Parameter	Symbol	Values	Unit
Drain-source voltage	V <sub>DS</sub>	60	V
Drain-gate voltage, $R_{\rm GS}$ = 20 k $\Omega$	$V_{\rm DGR}$	60	
Gate-source peak voltage, aperiodic	$V_{ m gs}$	± 20	
Gate-source voltage	V <sub>GS</sub>	± 10	
Continuous drain current, $T_{\rm C}$ = 25 °C	ID	24	Α
ISO drain current $T_{\rm C}$ = 85 °C, $V_{\rm GS}$ = 10 V, $V_{\rm DS}$ = 0.5 V	I <sub>D-ISO</sub>	6.0	
Pulsed drain current, $T_{\rm C} = 25  ^{\circ}{\rm C}$	I <sub>D puls</sub>	96	
Short circuit current, $T_j = -55 \dots + 150 \text{ °C}$	I <sub>SC</sub>	80	
Short circuit dissipation, $T_j = -55 \dots + 150 \text{ °C}$	P <sub>SCmax</sub>	1200	W
Power dissipation	P <sub>tot</sub>	75	
Operating and storage temperature range	$T_{\rm j}$ , $T_{\rm stg}$	- 55 + 150	°C
DIN humidity category, DIN 40 040	_	E	-
IEC climatic category, DIN IEC 68-1	-	55/150/56	
Thermal resistance			K/W
Chip-case Chip-ambient	$R_{ m th~JC} \ R_{ m th~JA}$	≤ 1.67 ≤ 75	



## **Electrical Characteristics**

at  $T_{\rm j}$  = 25 °C, unless otherwise specified.

Parameter	Symbol		Values		Unit
		min.	typ.	max.	

## **Static Characteristics**

Drain-source breakdow $V_{\rm GS}$ = 0, $I_{\rm D}$ = 0.25 mA	wn voltage	$V_{\rm (BR)DSS}$	60	_	_	V
Gate threshold voltage $V_{\text{GS}} = V_{\text{DS}}, I_{\text{D}} = 1 \text{ mA}$	)	$V_{\rm GS(th)}$	1.5	2.0	2.5	
Zero gate voltage drai $V_{GS} = 0 V, V_{DS} = 60 V$	n current	I <sub>DSS</sub>				μA
	$T_{\rm j}$ = 25 °C $T_{\rm j}$ = 125 °C		-	1 100	10 300	
Gate-source leakage of $V_{GS} = 20 \text{ V}, V_{DS} = 0$	current	I <sub>GSS</sub>				
	$T_{\rm j}$ = 25 °C $T_{\rm j}$ = 150 °C			10	100	nA μA
Drain-source on-state $V_{\rm GS}$ = 4.5 V, $I_{\rm D}$ =12 A	resistance	R <sub>DS(on)</sub>	_	0.055	0.065	Ω

# **Dynamic Characteristics**

Forward transconductance	g <sub>fs</sub>				S
$V_{\text{DS}} \ge 2 \times I_{\text{D}} \times R_{\text{DS(on)max}}, I_{\text{D}} = 12 \text{ A}$		12	17	22	
Input capacitance	$C_{\rm iss}$				pF
$V_{\rm GS} = 0, V_{\rm DS} = 25 \text{ V}, f = 1 \text{ MHz}$		800	1050	1400	
Output capacitance	C <sub>oss</sub>				
$V_{\rm GS}$ = 0, $V_{\rm DS}$ = 25 V, $f$ = 1 MHz		-	500	750	
Reverse transfer capacitance	$C_{\rm rss}$				
$V_{\rm GS} = 0, \ V_{\rm DS} = 25 \ V, f = 1 \ MHz$		-	200	300	
Turn-on time $t_{on}$ , $(t_{on} = t_{d(on)} + t_r)$	t <sub>d(on)</sub>	_	25	40	ns
$V_{\rm CC} = 30 \text{ V}, V_{\rm GS} = 5 \text{ V}, I_{\rm D} = 3 \text{ A}, R_{\rm GS} = 50 \Omega$	t <sub>r</sub>	-	150	200	
Turn-off time $t_{off}$ , $(t_{off} = t_{d(off)} + t_{f})$	t <sub>d(off)</sub>	-	180	250	
$V_{\rm CC} = 30 \text{ V}, V_{\rm GS} = 5 \text{ V}, I_{\rm D} = 3 \text{ A}, R_{\rm GS} = 50 \Omega$	t <sub>f</sub>	-	125	160	



# Electrical Characteristics (cont'd)

at  $T_i = 25 \,^{\circ}$ C, unless otherwise specified.

Parameter	Symbol		Values		Unit
		min.	typ.	max.	

### **Reverse Diode**

Continuous source current	Is	_	-	24	A
Pulsed source current	I <sub>SM</sub>	_	_	96	
Diode forward on-voltage $I_{\rm F}$ = 24 A, $V_{\rm GS}$ = 0 V	$V_{ m SD}$	_	1.3	1.8	V
Reverse recovery time $I_{\rm F} = I_{\rm S},  {\rm d}i_{\rm F}/{\rm d}t = 100  {\rm A}/{\rm \mu s},  V_{\rm R} = 30  {\rm V}$	t <sub>rr</sub>	_	150	_	ns
Reverse recovery charge $I_{\rm F} = I_{\rm S},  {\rm d}i_{\rm F}/{\rm d}t = 100  {\rm A}/{\rm \mu s},  V_{\rm R} = 30  {\rm V}$	Qrr	_	1.0	_	μC

## **Temperature Sensor**

Forward voltage	$V_{ m TS(on)}$				V
$I_{\text{TS(on)}} = 5 \text{ mA}, T_j = -55 \dots + 150 \text{ °C}$		-	1.3	1.4	
Sensor override, $t_p \le 100 \ \mu s$ $T_j = -55 \ + 160 \ ^{\circ}C$		_	_	10	
Forward current $T_{\rm j} = -55 \dots + 150 ^{\circ}{\rm C}$ Sensor override, $t_{\rm p} \le 100 \mu{\rm s}$	I <sub>TS(on)</sub>	_	_	5	mA
$T_{\rm j} = -55 \dots + 160 ^{\circ}{\rm C}$		_	_	600	
Holding current, $V_{TS(off)} = 5 V$ , $T_j = 2$ $T_j = 1$	25 °C <i>I</i> <sub>H</sub> 150 °C	0.05 0.05	0.1 0.2	0.5 0.3	
Switching temperature $V_{\text{TS}} = 5 \text{ V}$	$T_{TS(on)}$	150	_	_	°C
Turn-off time $V_{\text{TS}} = 5 \text{ V}, I_{\text{TS(on)}} = 2 \text{ mA}$	t <sub>off</sub>	0.5	_	2.5	μs

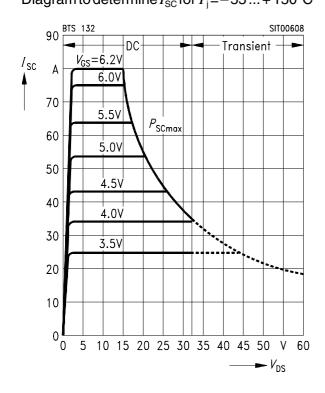


## **Examples for short-circuit protection**

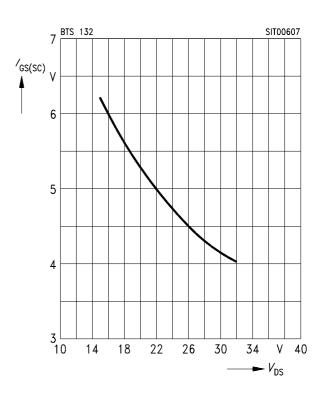
at  $T_i = -55 \dots + 150 \text{ °C}$ , unless otherwise specified.

Parameter	Symbol	Examples			Unit
		1	2	-	
Drain-source voltage	$V_{DS}$	15	30	_	V
Gate-source voltage	V <sub>GS</sub>	6.2	4.1	_	
Short-circuit current	I <sub>SC</sub>	≤ 80	≤ 37	_	А
Short-circuit dissipation	P <sub>SC</sub>	1200	1100	_	W
Response time $T_{\rm j}$ = 25 °C, before short circuit	t <sub>SC(off)</sub>	25	25	_	ms

Short-circuit protection  $I_{SC} = f(V_{DS})$ Parameter:  $V_{GS}$ Diagram to determine  $I_{SC}$  for  $T_i = -55 \dots + 150$  °C

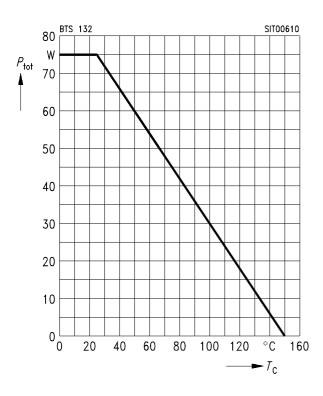


Max. gate voltage  $V_{GS(SC)} = f(V_{DS})$ Parameter:  $T_j = -55 \dots + 150 \text{ °C}$ 

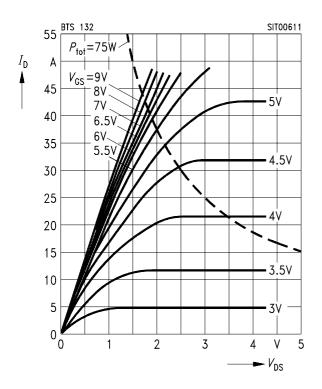




Max. power dissipation  $P_{\text{tot}} = f(T_{\text{C}})$ 

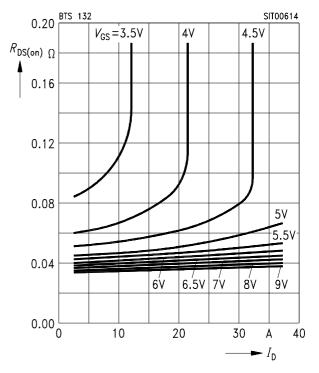


**Typical output characteristics**  $I_{D} = f(V_{DS})$ Parameter:  $t_{p} = 80 \ \mu s$ 

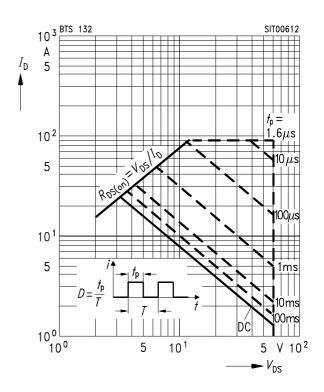


Typ. drain-source on-state resistance  $R_{\text{DS(on)}} = f(I_{\text{D}})$ 

Parameter:  $V_{\rm GS}$ 



Safe operating area  $I_{\rm D} = f(V_{\rm DS})$ Parameter: D = 0.01,  $T_{\rm C} = 25 \ ^{\circ}{\rm C}$ 

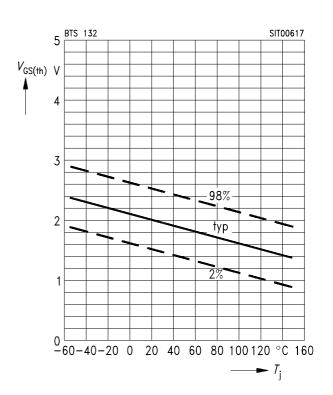




Drain-source on-state resistance

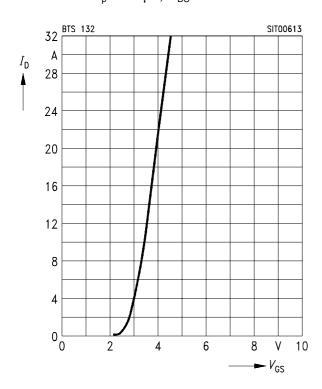
# $R_{\rm DS(on)} = f(T_{\rm i})$ Parameter: $I_D = 12 \text{ A}$ , $V_{GS} = 4.5 \text{ V}$ (spread) 0.15 BTS 132 SIT00615 $R_{\rm DS(on)}^{\Omega}$ 0.10 98% typ 0.05 0.00 └─ \_80 -40 0 40 80 120 °C 160 ► 7<sub>i</sub>

Gate threshold voltage  $V_{GS(th)} = f(T_j)$ Parameter:  $V_{DS} = V_{GS}$ ,  $I_D = 1$  mA

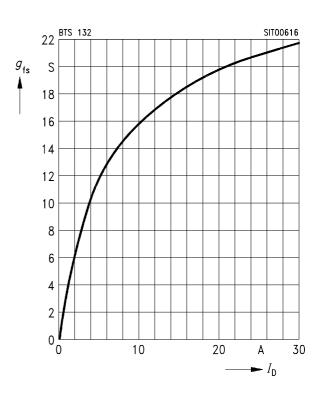


## Typ. transfer characteristic

 $I_{\rm D} = f(V_{\rm GS})$ Parameter:  $t_{\rm p} = 80 \ \mu \text{s}, V_{\rm DS} = 25 \ \text{V}$ 



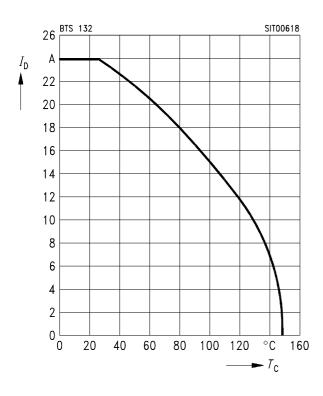
**Typ. transconductance**  $g_{fs} = f(I_D)$ Parameter:  $t_p = 80 \ \mu s$ ,  $V_{DS} = 25 \ V$ 





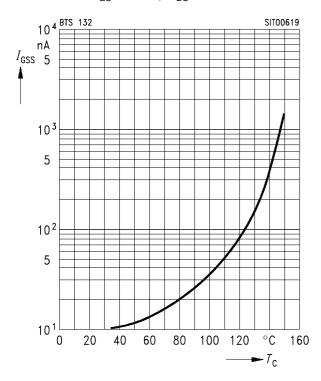
Continuous drain current  $I_{\rm D} = f(T_{\rm C})$ 

Parameter:  $V_{\rm GS} \ge 4.5 \text{ V}$ 



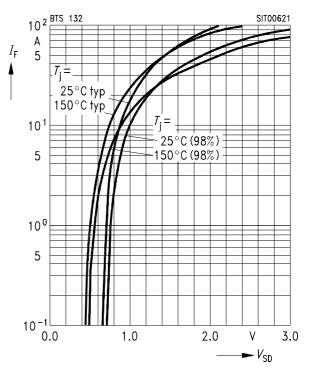
Typ. gate-source leakage current  $I_{\text{GSS}} = f(T_{\text{C}})$ 

Parameter:  $V_{GS} = 10 \text{ V}, V_{DS} = 0$ 

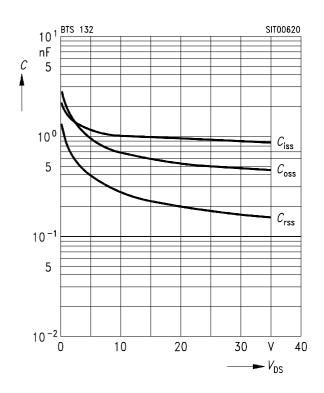


Forward characteristics of reverse diode  $I_{\rm F}$  =  $f\left(V_{\rm SD}\right)$ 

Parameter:  $T_j$ ,  $t_p = 80 \ \mu s$  (spread)



**Typ. capacitances**  $C = f(V_{DS})$ Parameter:  $V_{GS} = 0, f = 1$  MHz

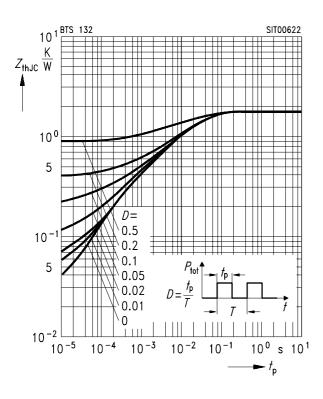




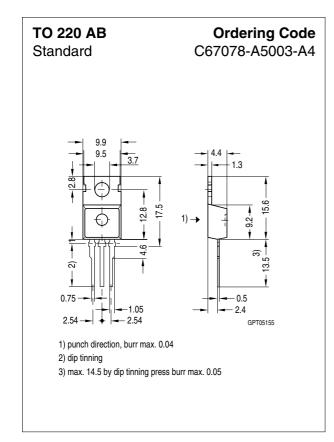


# Transient thermal impedance $Z_{\text{thJC}} = f(t_{\text{p}})$

Parameter:  $D = t_p/T$ 









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